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**APPLICATION NOTE 5966** 

# CHOOSING THE OPTIMAL CLOCK MODE FOR MAX116XX, MAX123X, AND MAX103X SAR ADCS

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Abstract: The MAX116xx, MAX103x, and MAX123x families of low-power, multichannel, 300ksps SAR ADCs have configurable clock modes that enable flexibility when interfacing with a SPI master. This application note discusses the advantages of each clock mode and provides timing examples for each mode.

#### Choosing the Right Clock Mode for an Application

The MAX116xx, MAX103x, and MAX123x families of low-power, multichannel, 300ksps SAR ADCs have configurable clock modes that enable flexibility when interfacing with a SPI master. The four different clock modes allow the system designer to configure the throughput, pin count, and sample trigger. For designs with limited hardware pins available, only four lines are required to operate these ADCs in clock modes 10 and 11. For highest throughput, clock mode 11 can be used to clock the conversion as data is simultaneously read out. If precise control over the sampling instant is required, clock mode 01 provides the system designer the ability to exactly trigger each acquisition externally. For systems with additional hardware resources, clock modes 00, 01, and 10 provide a hardware indicator, active-low EOC, to signal the end of conversion. A summary of the tradeoffs of using each clock mode is shown in **Table 1**.

	Pin Count	Acquisition Timing	Acquisition Trigger	Averaging	Throughput
Mode 00	5 or 6 pins	1st Acquisition Only	Active-low CNVST	Yes	Medium
Mode 01	5 or 6 pins	Every Acquisition	Active-low CNVST	Yes	Low
Mode 10	4 or 5 pins	1st Acquisition Only	Active-low CS	Yes	Medium
Mode 11	4 pins	Every Acquisition	SCLK	No	High

#### Table 1. Summary of Clock Mode Differences

#### Using Clock Mode 00

This clock mode uses five or six hardware pins and gives control over the initial acquisition timing only. In clock mode 00, acquisitions and conversions are both internally timed. After the voltage reference is chosen and the Averaging register is configured, all of the requested acquisitions and conversions across all channels can be initiated by a single active-low CNVST assert pulse. It is always best practice to clear the internal FIFO before initiating a series of conversions. To clear the FIFO without changing any of the register settings, write an input data byte of 0x18 to the device. Before initiating any conversions in clock mode 00, the conversion byte must be written before asserting active-low CNVST. Without writing the conversion byte before each series of data acquisitions/conversions, there will be no output data. This process is outlined in **Figure 1**.

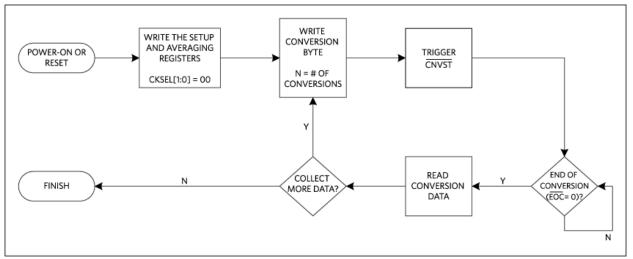


Figure 1. Clock mode 00 flow chart.

Once the conversion byte is written, pulse active-low CNVST low for at least 40ns. Following this time period, the rising edge of active-low CNVST starts the acquisitions and conversions. Once all of the conversions are complete, the active-low EOC pin will go low, indicating the end of conversion. Since all of the acquisitions and conversions are internally timed, the time between the rising edge of active-low CNVST and falling edge of active-low EOC depends on the number of channels, scan mode, and averaging mode selected. Ensure that the master waits for active-low EOC to go low, since accessing the data before a conversion is complete can corrupt the data. However, if the total conversion time is properly calculated, a timed delay can be used following the start trigger instead of polling active-low EOC to reduce the total interface pin count.

#### Clock Mode 00 Example 1 – Single-Channel Conversion, No Averaging (MAX11635)

Writing the following register settings in **Table 2**, the MAX11635 is configured for a single conversion on channel 0 using clock mode 00, internal +2.5V reference always-on, single-ended operation, and no averaging.

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Byte
Setup	0	1	CKSEL[1:0] =	00	REFSEL 10	_[1:0] =	(DIFFSEI	_[1:0] = 00)	0x48
Averaging	0	0	1	AVGON = 0	NAVG[1	:0] = 00	NSCAN[1	0] = 00	0x20
Conversion	1	Х	(CHSEL2 = 0)	CHSEL[1:0]	= 00	SCAN[1	:0] = 00	Х	0x80

#### Table 2. Mode 00 Single-Channel Settings

Since the internal reference is used and always on, assuming a low source impedance, the expected total conversion time is:

 $Total \ Conversion \ Time = (t_{ACQ(max)} + t_{CONV(max)}) \times n_{AVG} \times n_{RESULT} + t_{RP} = (1.4 \mu s \ (typ) + 3.5 \mu s \ (typ)) \times 1 \times 1 + 0 = 4.9 \mu s \ (typ) \times 1 \times 1 + 0 = 4.9 \mu s \ ($ 

In Figure 2, active-low EOC goes low 5.2µs after the rising edge of active-low CNVST.

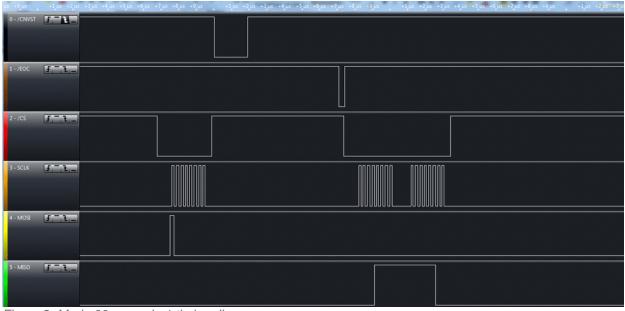


Figure 2. Mode 00 example 1 timing diagram.

#### Clock Mode 00 Example 2 – Four-Channel Scan, 32x Averaging (MAX11635)

Writing the following register settings in **Table 3**, the MAX11635 is configured to scan channel 0 through channel 3 using clock mode 00, internal +2.5V reference always-on, single-ended operation, and 32x averaging. The data returned will be the averaged result of each channel, so only four bytes are expected in the order channel 0, channel 1, channel 2, channel 3.

	Bit	Bit							
	7	6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Byte
Setup	0	1	CKSEL[1:0] =	00	REFSEI 10	_[1:0] =	(DIFFSE	L[1:0] = 00)	0x48
Averaging	0	0	1	AVGON = 1	NAVG[1	:0] = 11	NSCAN[	1:0] = 00	0x3C
Conversion	1	Х	(CHSEL2 = 0)	CHSEL[1:0]	= 11	SCAN[1	:0] = 00	Х	0x98

#### Table 3. Mode 00 Scanning and Averaging Settings

Since the internal reference is used and always on, assuming a low source impedance, the expected total conversion time is:

Total Conversion Time =  $(t_{ACQ(max)} + t_{CONV(max)}) \times n_{AVG} \times n_{RESULT} + t_{RP} = (1.4 \mu s (typ) + 3.5 \mu s (typ)) \times 32 \times 4 + 0 = 627.2 \mu s$ 

In **Figure 3**, active-low EOC goes low 587.6<sup>+</sup><sub>2</sub>0s after the rising edge of active-low CNVST.

+0.5 ms	+0.7 ms +0.8 r	ns +0.9 ms	+0.1 ms	+0.2 ms	+0.3 ms	+0.4 ms	+0.5 ms	+0.6 ms
0 - /CNVST								
1 - /EOC								
2-/CS								
3- SCLK <b>F</b>								
4 - MOSI								
S - MISO								

Figure 3. Mode 00 example 2 timing diagram.

#### Using Clock Mode 01

This clock mode uses five or six hardware pins and gives control over every single acquisition trigger. In clock mode 01, acquisitions are timed through the active-low CNVST pin and conversions are internally timed. Before initiating any conversions in clock mode 01, the conversion byte must be written before asserting active-low CNVST. For single acquisitions/conversions, this clock mode is identical to clock mode 00. However, if multiple conversions are requested, a separate active-low CNVST pulse is required to trigger each acquisition. **Figure 4** summarizes the serial data flow for clock mode 01.

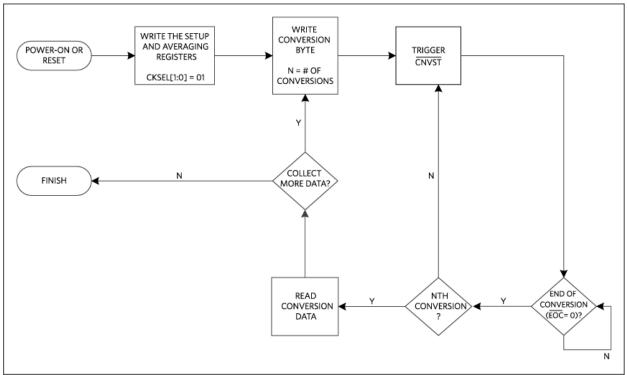


Figure 4. Clock mode 01 flow chart.

Once the conversion byte is written, pulse active-low CNVST low for at least 1.4µs. Note that this time is significantly longer than the 40ns specified for clock mode 00; please refer to the specific device data sheet for exact timing details. Following this time period, the rising edge of active-low CNVST starts the first acquisition and conversion. The active-low EOC pin will go low once each conversion is complete. If a second active-low CNVST pulse is sent before active-low EOC goes low, the output data may be corrupted. Once all of the requested conversions are complete, the active-low EOC pin will assert low and the data can be read.

#### Clock Mode 01 Example 1 – Single-Channel Conversion, 4x Averaging (MAX11635)

Writing the following register settings in **Table 4**, the MAX11635 is configured for a single-channel conversion on channel 0 using clock mode 01, internal +2.5V reference always-on, single-ended operation, with 4x averaging. Even though a single output code will be read, four active-low CNVST pulses will need

to be sent to acquire the 4 samples for averaging.

	Bit	Bit		0 0 0					
	7	6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Byte
Setup	0	1	CKSEL[1:0] =	01	REFSEL 10	[1:0] =	(DIFFSEI	L[1:0] = 00)	0x58
Averaging	0	0	1	AVGON = 1	NAVG[1	:0] = 00	NSCAN[1	00 = [0:1	0x30
Conversion	1	Х	(CHSEL2 = 0)	CHSEL[1:0]	= 00	SCAN[1	:0] = 00	Х	0x80

#### Table 4. Mode 01 Single-Channel 4x Averaging Settings

Since the total conversion time depends on when active-low CNVST is pulsed, there is not an exact estimate for the total time required. An example SPI transaction for clock mode 01 is shown in **Figure 5**.

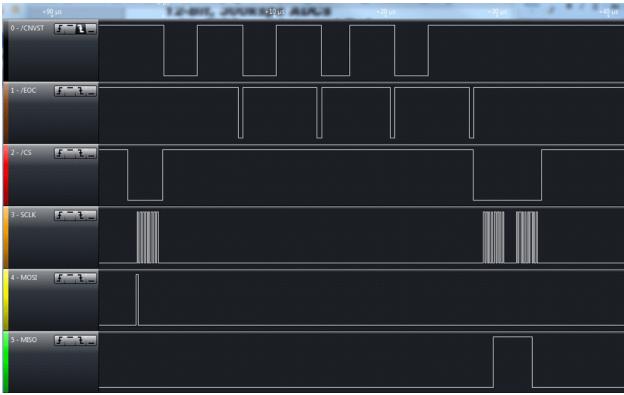


Figure 5. Mode 01 example 1 timing diagram.

# Clock Mode 01 Example 2 – Four-Channel Conversion, 8x Averaging (MAX11635)

Writing the following register settings in **Table 5**, the MAX11635 is configured to scan channel 0 through channel 3 using clock mode 01, internal +2.5V reference always-on, single-ended operation, with 8x averaging. Sampling four channels at eight acquisitions per channel will require a total of 32 active-low CNVST pulses to complete all requested conversions. **Figure 6** shows another timing example for clock mode 01 with averaging and channel scanning enabled.

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Byte
Setup	0	1	CKSEL[1:0] = (		REFSEL			.[1:0] = 00)	
	-		L - J	-	10			L - J /	
Averaging	0	0	1	AVGON = 1	NAVG[1:	0] = 01	NSCAN[1	:0] = 00	0x34
Conversion	1	Х	(CHSEL2 = 0)	CHSEL[1:0]	= 11	SCAN[1:	0] = 00	Х	0x98
φμs +5φμs +6φμs +7φμs + ο-/CNVST <b>Γ΄ τ</b>	80 µs +90 µs	-10 µs +20 µ	s +30,µs +40,µs +50,µs +60,µs +7	ο <sup>μς</sup> +8ξμς +9ξμς <b>-1</b>	၂ [ ] [ ] [ ] [ ] [ ] [ ] [ ] [ ] [ ] [	40jus +50jus +60jus +	, 10000	- 10 us +20 us +30 us +30 us	ıs +40 us +50 us

#### Table 5. Mode 01 Four-Channel 8x Averaging Settings



Figure 6. Mode 01 example 2 timing diagram.

## Using Clock Mode 10

This clock mode uses four or five hardware pins and gives control over the initial acquisition timing only. In clock mode 10, acquisitions and conversions are both internally timed. Unlike clock mode 00, the acquisition/conversion process is initiated by the rising edge of active-low CS and not the rising edge of active-low CNVST. This mode adds the advantage of reducing the required hardware pins at the expense of exact timing control through the use of active-low CNVST. The conversion sequence starts after writing the conversion byte when active-low CS is brought high. The process for using clock mode 10 is shown in **Figure 7**.

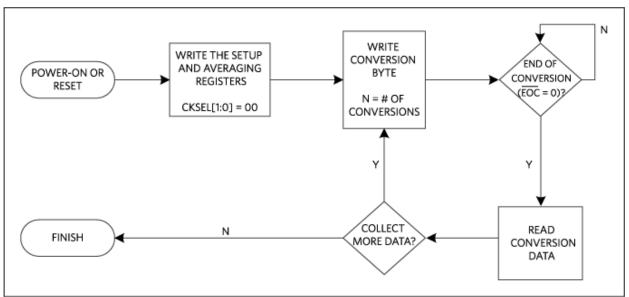


Figure 7. Clock mode 10 flow chart.

Once all of the conversions are complete, the active-low EOC pin will go low, indicating the end of conversion. Since all of the acquisitions and conversions are internally timed, the time between the rising edge of active-low CNVST and falling edge of active-low EOC depends on the number of channels and averaging selected by the conversion byte. Please refer to the device data sheet for equations to estimate the total conversion time.

## Clock Mode 10 Example 1 – Four-Channel Scan, 32x Averaging (MAX11635)

Writing the following register settings in **Table 6**, the MAX11635 is configured to scan channel 0 through channel 3 using clock mode 10, internal +2.5V reference always-on, single-ended operation, and 32x averaging. The data returned will be the averaged result of each channel, so only four bytes are expected in the order channel 0, channel 1, channel 2, channel 3.

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Byte
Setup	0	1	CKSEL[1:0] =	10	REFSEL 10	[1:0] =	(DIFFSEL	.[1:0] = 00)	0x68
Averaging	0	0	1	AVGON = 1	NAVG[1:	:0] = 11	NSCAN[1	:0] = 00	0x3C
Conversion	1	Х	(CHSEL2 = 0)	CHSEL[1:0]	= 11	SCAN[1:	0] = 00	Х	0x98

#### Table 6. Mode 10 Four-Channel 32x Averaging Settings

Since the internal reference is used and always on, assuming a low source impedance, the expected total conversion time is:

Total Conversion Time =  $(t_{ACQ(max)} + t_{CONV(max)}) \times n_{AVG} \times n_{RESULT} + t_{RP} = (1.4 \mu s (typ) + 3.5 \mu s (typ)) \times 32 \times 4 + 0 = 627.2 \mu s$ 

In Figure 8, active-low EOC goes low 587.0µs after the rising edge of active-low CS.

	+0.9 ms	•	+0.1 ms	+0.2 ms	+0.3ٍ ms	+0.4 ms	+0.5 ms	+0.6ٍ ms
1 - /EOC	[ <b>J</b> <sub>1</sub> <sup>-</sup> , <b>Z</b> <sub>1</sub> -]							
2 - /CS	<u>, , , , , , , , , , , , , , , , , , , </u>							
3 - SCLK	£ - 1 -							
4 - MOSI	<u>}</u> }_							
5 - MISO	<u>};</u> }_							

Figure 8. Mode 10 example timing diagram.

#### Using Clock Mode 11

This clock mode uses four hardware pins and only gives the designer control over the conversion clock rate. In clock mode 11, both acquisitions and conversions are timed externally through the SPI interface pins. Active-low CNVST and active-low EOC are unused, and both scanning and averaging are disabled in this clock mode. When writing the conversion byte, the acquisition is triggered on the SCLK falling edge immediately following the CHSEL channel select bits. The SCAN[1:0] bits in the conversion byte are unused in this clock mode, as scanning is disabled and the voltage acquisition has already started when they are clocked out. The acquisition finishes on the falling edge of the first bit of the next SPI input. This means that, if continuously clocked, three SCLK periods are used for the acquisition time. In order to satisfy the 0.6µs minimum acquisition time (longer time is required for non-zero source impedances), the maximum SCLK frequency that is used in this clock mode is 4.8MHz. Three clock cycles at this frequency take a total time of 0.625µs.

**Figure 9** shows the flow required to use clock mode 11. After writing the conversion byte, the following 16 SCLK cycles are used to clock out the requested sample. The first 8 SCLK cycles immediately following a conversion byte should not be used to initiate another conversion. However, the second 8 SCLK cycles can

be used to simultaneously clock out the LSB of output data and clock in the next conversion byte. Ensure that active-low CS is pulsed high for no more than 100µs between the first set 8 SCLK cycles and second set of SCLK cycles. Writing a conversion byte in every other 8-bit SPI access will yield the maximum output data rate possible in clock mode 11. Once the device is configured, active-low CS can be kept low to continuously initiate new conversions and clock out the resulting data.

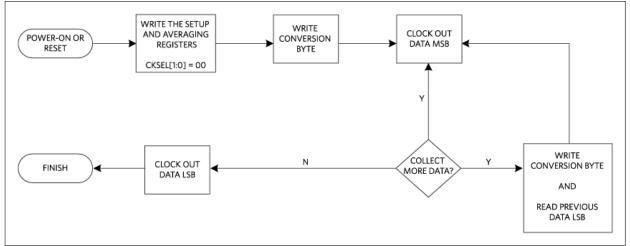


Figure 9. Clock mode 11 flow chart.

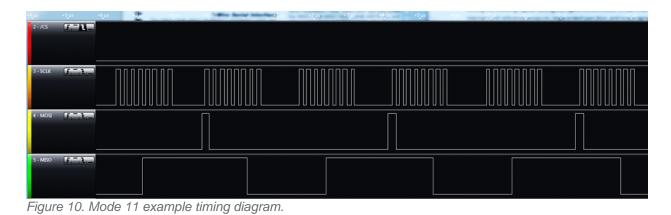
#### Clock Mode 11 Example 1 – Single-Channel Scan, No Averaging (MAX11635)

Writing the following register settings in Table 7, the MAX11635 is configured to scan channel 0 using clock mode 11, internal +2.5V reference always-on, single-ended operation, and no averaging (disabled by default).

	Bit	Bit							
	7	6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Byte
Setup	0	1	CKSEL[1:0] =	11	REFSEL 10	[1:0] =	(DIFFSEL	_[1:0] = 00)	0x78
Averaging	0	0	1	AVGON = 0	NAVG[1	:0] = 00	NSCAN[1	:0] = 00	0x20
Conversion	1	Х	(CHSEL2 = 0)	CHSEL[1:0]	= 00	SCAN[1:	0] = 00	Х	0x80

Table 7.	Mode	11	Single-Channel	Settings
	mouc		omgic-onamici	ocumga

The total conversion time in this clock mode is directly dependent on the SCLK period. Figure 10 shows an example of the maximum output data rate by sending a conversion byte every other 8-bit SPI transaction with a SCLK frequency of 4.8MHz.



#### Summary

The different clock modes in the MAX116xx, MAX103x, and MAX123x families of low-power, multichannel, 300ksps SAR ADCs arm system designers with a variety of design choices when choosing the best SPI interface. Acquisition and conversion timing, hardware event triggers, pin count, and maximum throughput are all affected by the interface chosen.

Related Parts		
MAX1030	10-Bit 300ksps ADCs with FIFO, Temp Sensor, Internal Reference	Free Samples
MAX1031	10-Bit 300ksps ADCs with FIFO, Temp Sensor, Internal Reference	Free Samples
MAX11624	10-Bit, 300ksps ADCs with FIFO and Internal Reference	Free Samples
MAX11625	10-Bit, 300ksps ADCs with FIFO and Internal Reference	Free Samples
MAX11632	12-Bit, 300ksps ADCs with FIFO and Internal Reference	Free Samples
MAX11633	12-Bit, 300ksps ADCs with FIFO and Internal Reference	Free Samples
MAX11634	12-Bit, 300ksps ADCs with Differential Track/Hold, and Internal Reference	Free Samples
MAX11635	12-Bit, 300ksps ADCs with Differential Track/Hold, and Internal Reference	Free Samples
MAX11642	8-Bit, 16-/8-Channel, 300ksps ADCs with FIFO and Internal Reference	Free Samples
MAX11643	8-Bit, 16-/8-Channel, 300ksps ADCs with FIFO and Internal Reference	Free Samples
MAX1230	12-Bit 300ksps ADCs with FIFO, Temp Sensor, Internal Reference	Free Samples

MAX1231	12-Bit 300ksps ADCs with FIFO, Temp Sensor, Internal	Free Samples
	Reference	

#### More Information

For Technical Support: http://www.maximintegrated.com/en/support For Samples: http://www.maximintegrated.com/en/samples Other Questions and Comments: http://www.maximintegrated.com/en/contact

Application Note 5966: http://www.maximintegrated.com/en/an5966

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